

Search Notes

Application/Control No.

10/538,193

Examiner

Muhammad Akbar

Applicant(s)/Patent under
Reexamination

HIRVONEN ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	67.11	3/20/2007	MA
455	81	3/20/2007	MA
455	575.8	3/20/2007	MA
455	115.1	3/20/2007	MA
455	226.1	3/20/2007	MA
455	227	3/20/2007	MA

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Words searches in EASt using class 455,340,342 subclass 67.11,115.1,226.1575.8,228	3/20/2007	MA
Words searches by using WWW with keywords RF device testing with waveguide	3/21/2007	MA
WIPO/ECS/IEEE documents searches by using keywords RF device testing with waveguide	3/21/2007	MA